

# FDMS8660S N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup> 30V, 40A, 2.4m $\Omega$

#### **Features**

- Max  $r_{DS(on)}$  = 2.4m $\Omega$  at  $V_{GS}$  = 10V,  $I_D$  = 25A
- Max  $r_{DS(on)}$  = 3.5m $\Omega$  at  $V_{GS}$  = 4.5V,  $I_D$  = 21A
- Advanced Package and Silicon combination for low R<sub>DS(ON)</sub> and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- RoHS Compliant



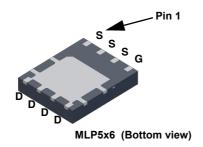
#### **General Description**

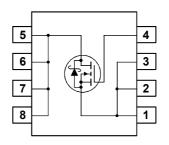
The FDMS8660S has been designed to minimize losses in power conversion applications. Advancements in both silicon and package technologies have been combined to offer the lowest  $R_{\text{DS(ON)}}$  while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

#### **Application**

Synchronous Rectifier for DC/DC Converters

- Notebook Vcore/ GPU low side switch
- Networking Point of Load low side switch
- Telecom secondary side rectification





#### **MOSFET Maximum Ratings** T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Parameter			Units
V <sub>DS</sub>	Drain to Source Voltage			30	V
V <sub>GS</sub>	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25°C		40	
I <sub>D</sub>	-Continuous (Silicon limited)	T <sub>C</sub> = 25°C		147	^
	-Continuous	T <sub>A</sub> = 25°C	(Note 1a)	25	A
	-Pulsed			200	
D	Power Dissipation	T <sub>C</sub> = 25°C		83	W
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25°C	(Note 1a)	2.5	VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case		1.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8660S	FDMS8660S	MLP5X6	13"	12mm	3000 units

Units

### Electrical Characteristics T<sub>J</sub> = 25°C unless otherwise noted **Parameter**

Off Char	acteristics					
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 1 \text{mA}, V_{GS} = 0 \text{V}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 1mA, referenced to 25°C		35		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V			500	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20V, V <sub>GS</sub> = 0V			±100	nA

**Test Conditions** 

#### On Characteristics (Note 2)

Symbol

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 1mA$	1	1.5	2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 1mA, referenced to 25°C		-6		mV/°C
		$V_{GS} = 10V, I_D = 25A$		1.9	2.4	
r <sub>DS(on)</sub>	Drain to Source On Resistance	$V_{GS} = 4.5V, I_D = 21A$		2.6	3.5	mΩ
		$V_{GS} = 10V$ , $I_D = 25A$ , $T_J = 125$ °C		2.9	3.9	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10V, I_D = 25A$		123		S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V - 45V V - 0V	4342	pF
Coss	Output Capacitance	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, f = 1MHz	1213	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112	425	pF
$R_{a}$	Gate Resistance	f = 1MHz	1.0	Ω

#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time	., , , , , , ,		17	31	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15V, I <sub>D</sub> = 1A		12	22	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10V, $R_{GEN}$ = $6\Omega$		76	122	ns
t <sub>f</sub>	Fall Time			50	80	ns
$Q_{g(TOT)}$	Total Gate Charge at 10V	V <sub>GS</sub> = 0V to 10V		81	113	nC
Q <sub>g(4.5V)</sub>	Total Gate Charge at 4.5V	$V_{GS} = 0V \text{ to } 4.5V$		44		
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 15V, I_{D} = 25A$ $V_{GS} = 10V$		11		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	VGS - 10V		16		nC

#### **Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 2.2A$ (Note 2)	0.37	0.7	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>E</sub> = 25A, di/dt = 300A/μs	35		ns
Q <sub>rr</sub>	Reverse Recovery Charge	1F - 25A, αι/αι - 300A/μS	98		nC

<sup>1.</sup> R<sub>0JA</sub> is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 50°C/W when mounted on a 1 in² pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

Scale 1: 1 on letter size paper

<sup>2:</sup> Pulse Test: Pulse Width <  $300\mu s$ , Duty cycle < 2.0%.

#### Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

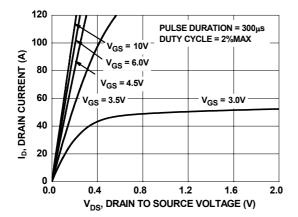


Figure 1. On Region Characteristics

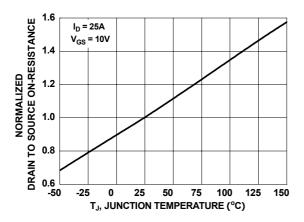


Figure 3. Normalized On Resistance vs Junction Temperature

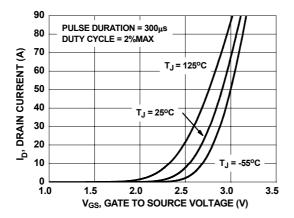


Figure 5. Transfer Characteristics

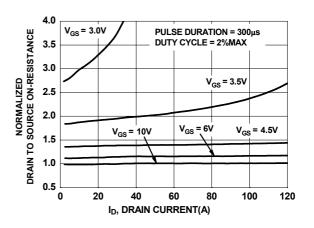


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

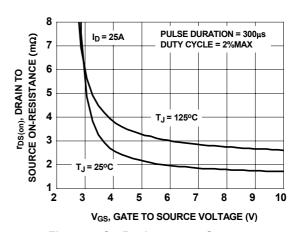


Figure 4. On-Resistance vs Gate to Source Voltage

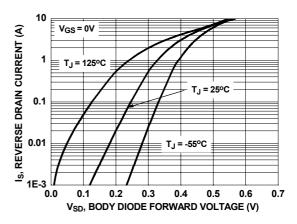


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

#### Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

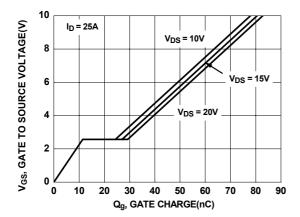


Figure 7. Gate Charge Characteristics

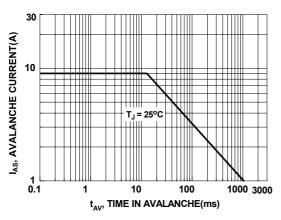


Figure 9. Unclamped Inductive Switching Capability

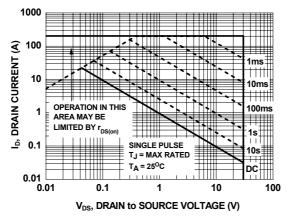


Figure 11. Forward Bias Safe Operating Area

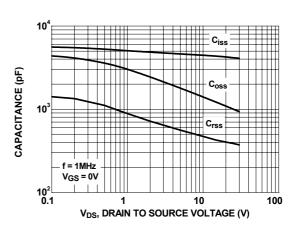


Figure 8. Capacitance vs Drain to Source Voltage

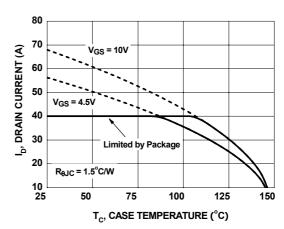


Figure 10. Maximum Continuous Drain Current vs Case Temperature

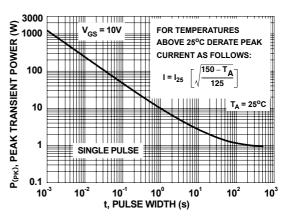


Figure 12. Single Pulse Maximum Power Dissipation

## Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

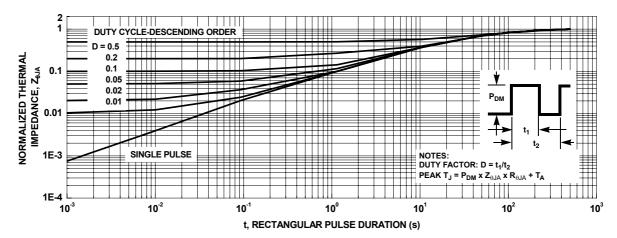


Figure 13. Transient Thermal Response Curve

#### Typical Characteristics (continued)

## SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMS8660S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

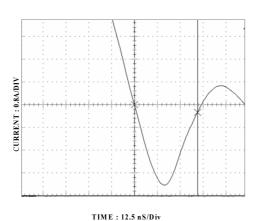


Figure 14. FDMS8660S SyncFET body diode reverse recovery characteristic

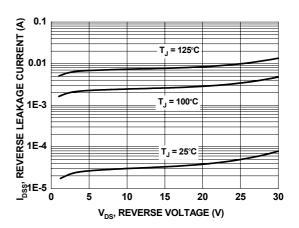
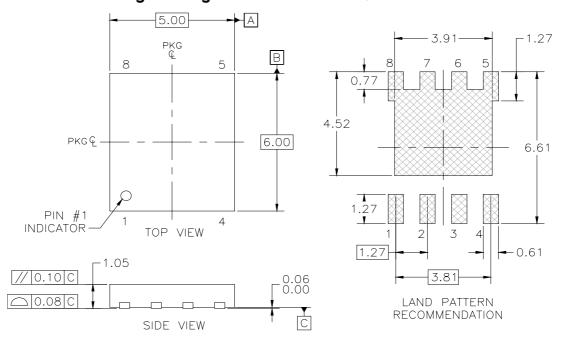
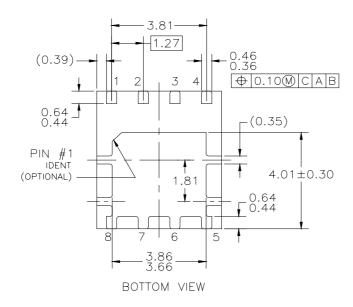


Figure 15. SyncFET body diode reverses leakage versus drain-source voltage

#### Power QFN, 8 Leads

#### Marketing drawing reference : MKT- PQFN08A rev. A





NOTES: UNLESS OTHERWISE SPECIFIED

- ALL DIMENSIONS ARE IN MILLIMETERS.
- NO JEDEC REFERENCE AS OF FEBRUARY 2006 DIMENSIONING AND TOLERANCING PER ASME Y14.5M 1994

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The Power Franchise®		ScalarPump™	UHC™			
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